Power MOSFET

60 V, 7.1 m Ω , 82 A, Single N–Channel

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- High Current Capability
- Avalanche Energy Specified
- AEC-Q101 Qualified
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T₁ = 25°C unless otherwise noted)

	ij = 25 C	unless otherw	nse noteu)		
Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	60	V
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain Cur-		$T_{C} = 25^{\circ}C$	I _D	82	А
rent $R_{\theta JC}$ (Note 1)	Steady	$T_{C} = 100^{\circ}C$		58	
Power Dissipation $R_{\theta JC}$	State	$T_{C} = 25^{\circ}C$	PD	96	W
(Note 1)		$T_{C} = 100^{\circ}C$		48	
Continuous Drain Cur-		T _A = 25°C	Ι _D	14.9	А
rent $R_{\theta JA}$ (Notes 1 & 2)	Steady	$T_A = 100^{\circ}C$		11.5	
Power Dissipation $R_{\theta JA}$	State	T _A = 25°C	PD	3.1	W
(Notes 1 & 2)		$T_A = 100^{\circ}C$		1.6	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \ \mu s$		I _{DM}	500	А
Current Limited by Package (Note 3)	$T_A = 25^{\circ}C$		I _{Dmaxpkg}	60	A
Operating Junction and S	storage Te	mperature	T _J , T _{stg}	–55 to 175	°C
Source Current (Body Diode)			۱ _S	82	А
Single Pulse Drain-to-Source Avalanche Energy (T _J = 25°C, V _{DD} = 50 V, V _{GS} = 10 V, $I_{L(pk)}$ = 23 A, L = 1.0 mH, R _G = 25 Ω)		E _{AS}	265	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Drain)	$R_{\theta JC}$	1.6	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	48	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.

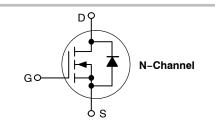
3. Continuous DC current rating. Maximum current for pulses as long as 1 second are higher but are dependent on pulse duration and duty cycle.



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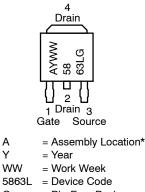
V _{(BR)DSS}	R _{DS(on)}	I _D	
60 V	7.1 mΩ @ 10 V	82 A	
	9.0 mΩ @ 4.5 V	02 A	





DPAK CASE 369AA **STYLE 2**

MARKING DIAGRAMS **& PIN ASSIGNMENT**



А γ

G

= Pb-Free Package

* The Assembly Location Code (A) is front side optional. In cases where the Assembly Location is stamped in the package bottom (molding ejecter pin), the front side assembly code may be blank.

ORDERING INFORMATION

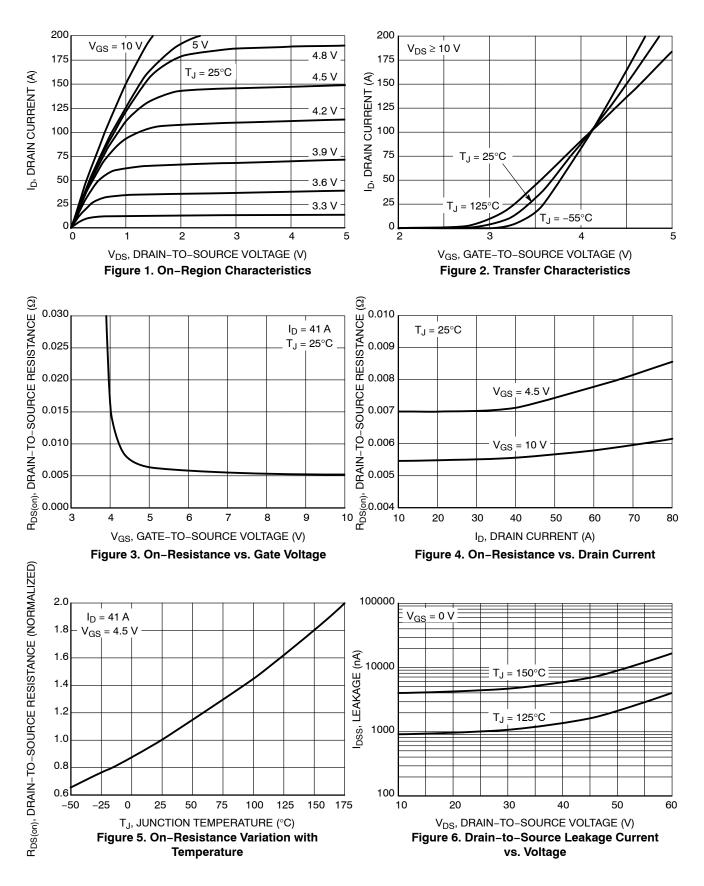
See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise noted)

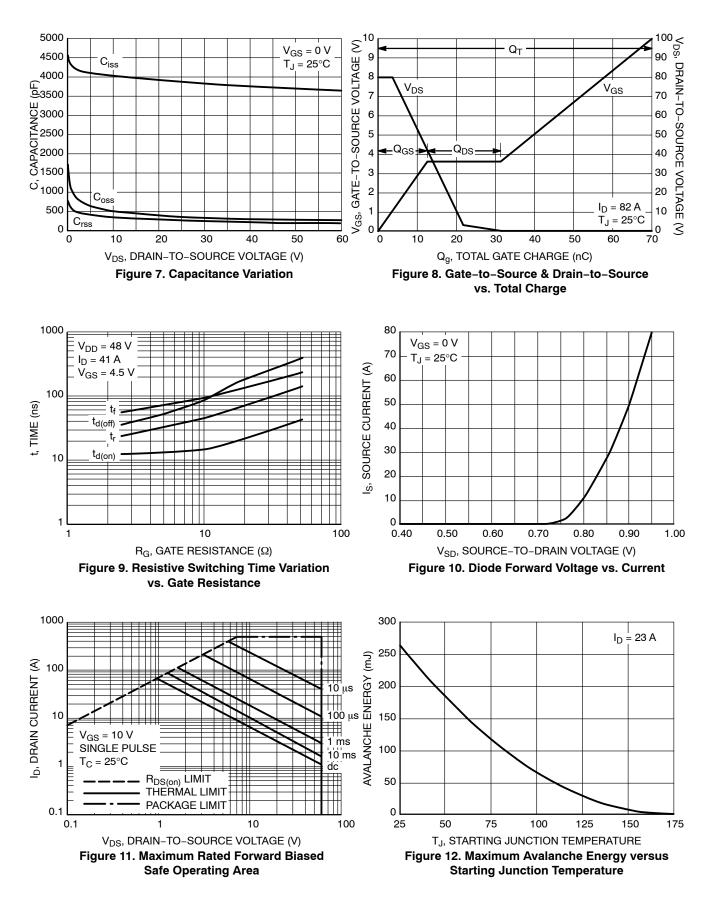
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I_D = 250 μ A		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				50		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{CS} = 0 V_{c}$	T _J = 25°C			1.0	μΑ
		V _{GS} = 0 V, V _{DS} = 48 V	T _J = 150°C			100	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	_s = ±20 V			±100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 250 μA	1.0		3.0	V
Negative Threshold Temperature Co- efficient	V _{GS(TH)} /T _J				6.7		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _[₎ = 41 A		5.6	7.1	mΩ
		V _{GS} = 4.5 V, I	_D = 41 A		7.2	9.0	1
CHARGES, CAPACITANCES AND GA	TE RESISTANCE	ES					•
Input Capacitance	C _{iss}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 25 V			3850		pF
Output Capacitance	C _{oss}				350		
Reverse Transfer Capacitance	C _{rss}	•DS - 20	, ,		220		
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 4.5 V, V_{DS} = 48 V, I_D = 41 A			36		nC
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 48 V, I _D = 41 A			70		1
Threshold Gate Charge	Q _{G(TH)}				3.7		
Gate-to-Source Charge	Q _{GS}				12.3		
Gate-to-Drain Charge	Q _{GD}				19.4		
SWITCHING CHARACTERISTICS (Not	e 5)						
Turn-On Delay Time	t _{d(on)}				12.8		ns
Rise Time	t _r	$V_{GS} = 10 V_{c} V_{T}$	ה = 48 V.		24.4		1
Turn-Off Delay Time	t _{d(off)}	V_{GS} = 10 V, V_{DD} = 48 V, I_{D} = 41 A, R_{G} = 2.5 Ω			37.6		1
Fall Time	t _f				55		1
DRAIN-SOURCE DIODE CHARACTER	RISTICS		I				
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V,$ $I_{S} = 41 A$	$T_J = 25^{\circ}C$		0.88	1.2	V
			T _J = 150°C		0.73		1
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dls/dt = 100 A/μs, I _S = 41 A			31		ns
Charge Time	ta				18		1
Discharge Time	tb				13		1
Reverse Recovery Charge	Q _{RR}				31		nC

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

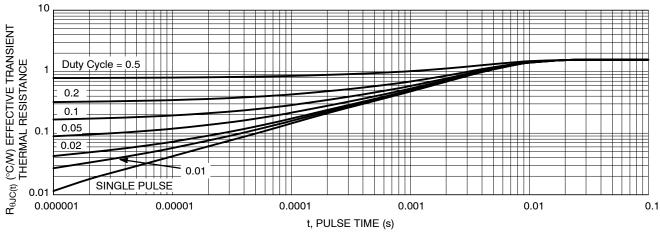


Figure 13. Thermal Response

ORDERING INFORMATION

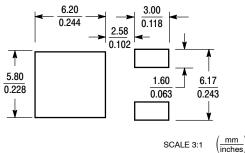
Order Number	Package	Shipping [†]
NVD5863NLT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NVD5863NLT4G-VF01	DPAK (Pb–Free)	2500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

1

L3

L4



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

DATE 03 JUN 2010

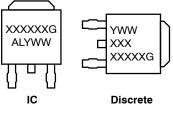
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

ON Semiconductor

- 2. CONTROLLING DIMENSION: INCHES. 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-
- THERMAL FAD CONTOR OF FIGURE WITHIN DEMONSIONS b3, L3 and Z.
 DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL
- NOT EXCEED 0.006 INCHES PER SIDE 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM

	INCHES		MILLIN	IETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.030	0.045	0.76	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
Е	0.250	0.265	6.35	6.73	
е	0.090	BSC	2.29 BSC		
Н	0.370	0.410	9.40	10.41	
Г	0.055	0.070	1.40	1.78	
L1	0.108	0.108 REF		2.74 REF	
L2	0.020 BSC		0.51 BSC		
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Ζ	0.155		3.93		

MARKING DIAGRAM*



= Device Code = Assembly Location L = Wafer Lot Y = Year = Work Week WW G = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking.

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